# MSKSEMI 美森科



ESD











GDT

PLED

MMBT3904LP(MS)

Product specification



#### MSKSEMI SEMICONDUCTOR

## Features

- Low profile package
- Ideal for automated placement
- Low saturation voltages
- High voltage capability
- High Stability and High Reliability
- RoHS Compliant

# Applications

- amplifying signal
- Electronic switch
- Oscillating circuit
- Variable resistance
- Lighting applications

# Appearance & Symbol

PACKAGE OUTLINE	Pin Configuration	Marking	
1: Base 2: Emitter 3: Collector DFN1006-3	Collector Base Emitter	6P	



#### Absolute Maximum Ratings (T=25°C unless otherwise noted)

Parameter	Symbol	Value	Unit
Collector-Base Voltage	V <sub>CBO</sub>	60	V
Collector-Emitter Voltage	V <sub>CEO</sub>	40	V
Emitter-Base Voltage	V <sub>EBO</sub>	6	V
Collector Current Continuous	lc	0.2	А
Power Dissipation	PD	0.3	W
Operating Junction temperature	TJ	-55 to +150	°C
Storage Temperature Range	T <sub>STG</sub>	-55 to +150	°C

## Electrical Characteristics (T=25°C unless otherwise noted)

Parameter	Symbol	Test conditions	Min	Тур	Max	Unit
Collector-Base Breakdown Voltage	V <sub>CBO</sub>	I <sub>C</sub> =10μΑ, I <sub>E</sub> =0	60			V
Collector-Emitter Breakdown Voltage	V <sub>CER</sub>	I <sub>C</sub> =1mA,I <sub>B</sub> =0	40			V
Emitter-Base Breakdown Voltage	V <sub>EBO</sub>	I <sub>E</sub> =10uA,I <sub>C</sub> =0	6			V
Collector Cut-Off Current	І <sub>сво</sub>	V <sub>CB</sub> =60V, I <sub>E</sub> =0			100	nA
Collector Cut-Off Current	ICEX	V <sub>CE</sub> =30V,V <sub>EB(off)</sub> =3V			50	nA
Emitter Cut-Off Current	I <sub>EBO</sub>	V <sub>EB</sub> =5V,I <sub>C</sub> =0			100	nA
	h <sub>FE</sub>	V <sub>CE</sub> =1V,I <sub>C</sub> =0.1mA	40			
		V <sub>CE</sub> =1V,I <sub>C</sub> =1mA	70			
DC current gain		V <sub>CE</sub> =1V,I <sub>C</sub> =10mA	100		300	
		V <sub>CE</sub> =1V,I <sub>C</sub> =50mA	60			
		V <sub>CE</sub> =1V,I <sub>C</sub> =100mA	30			
Collector-emitter saturation voltage	V <sub>CE(sat)</sub>	I <sub>C</sub> =50mA, I <sub>B</sub> =5mA			0.3	V
Base -emitter saturation voltage	V <sub>BE(sat)</sub>	I <sub>C</sub> =50mA, I <sub>B</sub> =5mA			0.95	V
Transition frequency	fT	V <sub>CE</sub> = 20V, I <sub>C</sub> =10mA,f=100MHz	300			MHZ
Delay Time	td	Vcc =3V, Ic = 10mA,		35		
Rise time	tr	$V_{BE(off)}$ =-0.5V, $I_{B1}$ =1mA		35		ns
Storage time	ts	Vcc =3V, Ic =10mA,		200		us
Fall time	tf	$I_{B1} = I_{B2} = 1mA$		50		ns

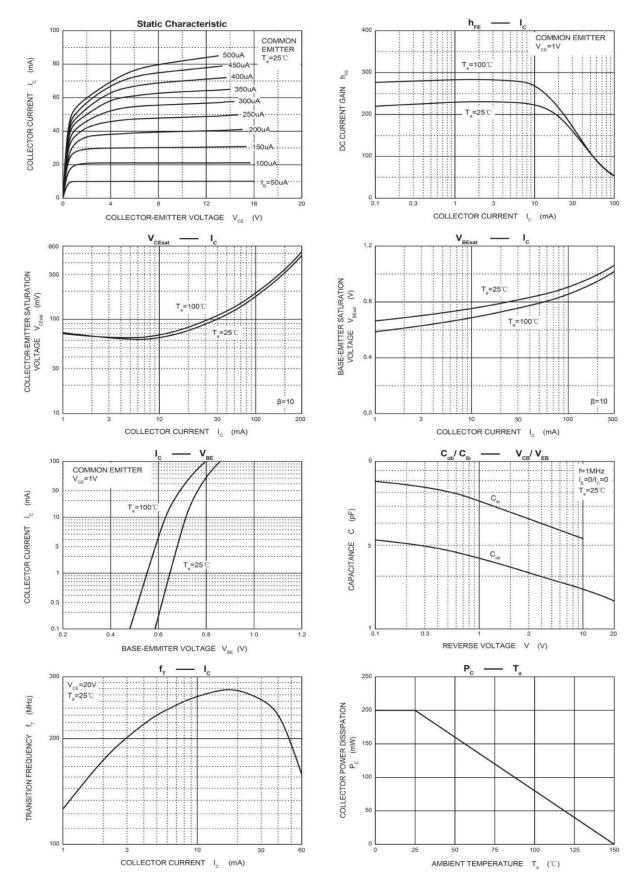
## Classification of hFE

Range

100-300



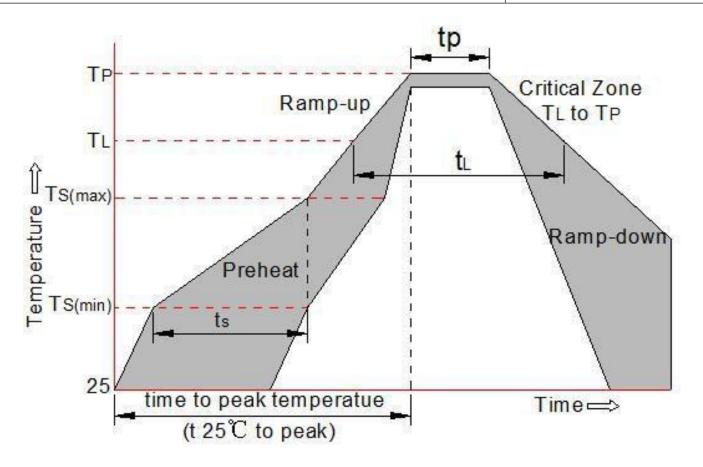
# **Typical Characteristics**





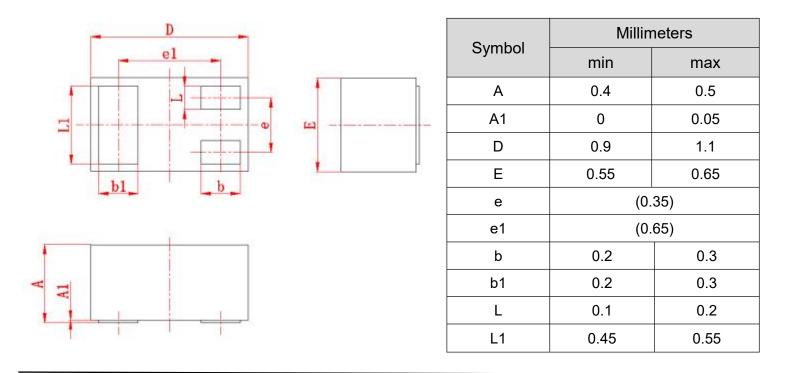
#### Soldering parameters

Reflow Condition		Pb-Free assembly (see as bellow)
-Temperature Min (T <sub>s(min)</sub> )		+150℃
Pre Heat	-Temperature Max(T <sub>s(max)</sub> )	<b>+200</b> ℃
	-Time (Min to Max) (ts)	60-180 secs.
Average	Average ramp up rate (Liquid us Temp (T∟) to peak)	
$T_{s(max)}$ to $T_L$ - Ramp-up Rate		3℃/sec. Max
	-Temperature(T <sub>L</sub> ) (Liquid us)	+217℃
Reflow	-Temperature(t <sub>∟</sub> )	60-150 secs.
Peak Temp (T <sub>p</sub> )		<b>+260(+0/-5)</b> ℃
Time within 5 $^\circ \!\!\! \mathbb{C}$ of actual Peak Temp (t_p)		30 secs. Max
Ramp-down Rate		6℃/sec. Max
Time 25 $^\circ C$ to Peak Temp (T <sub>P</sub> )		8 min. Max
Do not exceed		+260℃

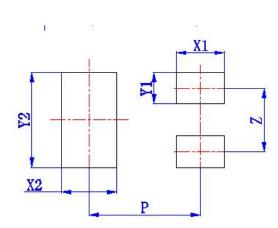




#### Package mechanical data



## Suggested Land Pattern



Symbol	Dimension in Millimeters	
	typ	
X1	(0.3)	
X2	(0.35)	
Y1	(0.2)	
Y2	(0.6)	
Z	(0.4)	
Р	(0.7)	

### **REEL SPECIFICATION**

P/N	PKG	QTY
MMBT3904LP(MS)	DFN1006-3	10000



#### **Attention**

Any and all MSKSEMI Semiconductor products described or contained herein do not have specifications that can handle applications that require extremely high levels of reliability, such as life-support systems, aircraft's control systems, or other applications whose failure can be reasonably expected to result in serious physical and/or material damage. Consult with your MSKSEMI Semiconductor representative nearest you before using any MSKSEMI Semiconductor products described or contained herein in such applications.

MSKSEMI Semiconductor assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all MSKSEMI Semiconductor products described or contained herein.

Specifications of any and all MSKSEMI Semiconductor products described or contained herein stipulate the performance, characteristics, and functions of the described products in the independent state, and are not guarantees of the performance, characteristics, and functions of the described products as mounted in the customer's products or equipment. To verify symptoms and states that cannot be evaluated in an independent device, the customer should always evaluate and test devices mounted in the customer's products or equipment.

MSKSEMI Semiconductor. strives to supply high-quality high-reliability products. However, any and all semiconductor products fail with someprobability. It is possible that these probabilistic failures could give rise to accidents or events that could endanger human lives, that could give rise to smoke or fire, or that could cause damage to other property. When designing equipment, adopt safety measures so that these kinds of accidents or events cannot occur. Such measures include but are not limited to protective circuits anderror prevention circuits for safedesign, redundant design, and structural design.

■ In the event that any or all MSKSEMI Semiconductor products (including technical data, services) described or contained herein are controlled under any of applicable local export control laws and regulations, such products must not be exported without obtaining the export license from theauthorities concerned in accordance with the above law.

■ No part of this publication may be reproduced or transmitted in any form or by any means, electronic or

mechanical, including photocopying and recording, or any information storage or retrieval system, or otherwise, without the prior written permission of MSKSEMI Semiconductor.

Information (including circuit diagrams and circuit parameters) herein is for example only ; it is not guaranteed for volume production. MSKSEMI Semiconductor believes information herein is accurate and reliable, but no guarantees are made or implied regarding its use or any infringements intellectual property rights or other rights of third parties.

Any and all information described or contained herein are subject to change without notice due to

product/technology improvement, etc. Whendesigning equipment, referto the "Delivery Specification" for the MSKSEMI Semiconductor productthat you intend to use.

# **X-ON Electronics**

Largest Supplier of Electrical and Electronic Components

Click to view similar products for Bipolar Transistors - BJT category:

Click to view products by MSKSEMI manufacturer:

Other Similar products are found below :

BC559C MCH4017-TL-H MMBT-2369-TR BC546/116 NJVMJD148T4G NTE16 NTE195A IMX9T110 2N4401-A 2N6728 2SA1419T-TD-H 2SB1204S-TL-E 2SC5488A-TL-H FMC5AT148 2N2369ADCSM 2N2907A 2N3904-NS 2N5769 2SC4618TLN CPH6501-TL-E US6T6TR BAX18/A52R BC556/112 IMZ2AT108 MMST8098T146 MCH6102-TL-E BC846B-13-F 2N3879 30A02MH-TL-E NTE13 NTE282 NTE323 NTE350 NTE81 JANTX2N2920L JANSR2N2907AUB CMLT3946EG TR SNSS40600CF8T1G CMLT3906EG TR GRP-DATA-JANS2N2907AUB GRP-DATA-JANS2N2222AUA MMDT3946FL3-7 2N4240 JANS2N3019 MSB30KH-13 2N2221AUB 2SD1815T-TL-E 2N6678 2N2907Ae4 JAN2N3507